

Notice of References Cited	Application/Control No. 10/786,495	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Sang Nguyen	Art Unit 2886	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,975,407	12-2005	Wang et al.	356/601
*	C	US-5,283,141	02-1994	Yoon et al.	430/30
*	D	US-4,890,239	12-1989	Ausschnitt et al.	430/30
*	E	US-5,283,141	02-1994	Yoon et al.	430/30
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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